

group of properties in both sections, an introduction outlines the theory, experimental procedures, and selected references.

The index must be used with care to find the specific property of a specific material. In checking for the specific material directly, I found references to figures or tabulations dealing only with that material. Much additional information exists in the collective tables, but can be found only by looking up the particular property. The publisher does not make the task any easier, since the running head at the top of the page identifies only Section 1 or Section 2. The table of contents is quite brief and appears in an inconspicuous spot on the back of the last page of the introductory matter.

A brief scan located just a few errors, judged to be minor. In checking on ZnS, I found Table 1.1.1.2 gives the β ZnS crystal system as cubic. Subsequent tables usually list merely "ZnS"; in Table 1.1.1.4.5 ZnS also appears in a hexagonal listing. In other places the listing is "ZnS (CVD)"; an examination of the data indicates that this must be the cubic form. Refractive index data on these materials are found in a variety of forms on pages 29, 31, 33, 234, 247, and 265. Some of these entries imply that ZnS is also available as "Irtran 2," for which "Infrared transmission" in the index also leads to additional data on page 242.

Having found some imperfections in this massive work, I can now complete my review by saying that I expect to find this volume very useful in my work and would hate to be without it. Most materials scientists will, I believe, feel the same way.

Reviewer: Kurt Nassau is a member of the technical staff at AT&T Bell Laboratories, Murray Hill, NJ.

Strong Metal-Support Interactions

Edited by R.T.K. Baker, S.J. Tauster, and J.A. Dumesic
(American Chemical Society, 1986)

This volume in the ACS Symposium Series presents the papers from a symposium held at the 189th Meeting of the American Chemical Society in Miami Beach, Florida, April 28 through May 3, 1985. It includes 21 papers discussing metal-support interactions, a topic of continuing interest among catalytic chemists but now of importance to those involved in understanding other materials, such as metal-metal oxide interfaces in electronics. This symposium focuses on those aspects strongly coupled to heterogeneous catalysis.

The topics range from a review, through detailed microscopic and kinetic characterizations of high-surface-area catalysts, to important studies of model systems. This book brings together the thinking of experts from around the world who are working in this area.

Because of the detailed nature of these papers which, for the most part, represent new and ongoing research, the book will be most valuable to experts in the field. However, Tauster's overview is particularly noteworthy in its attempt to assess the present status and understanding of this important field. As such, it will be of considerable interest to newcomers to metal-support interactions. While the center of gravity of the reported work lies in the popular metal-titania systems, other areas are given sufficient coverage to provide useful breadth and an indication of the generality of the important metal-support interactions.

As a participant in this field, I found the papers to be of uniformly high quality and to contain interesting observations and speculations which stimulated anew my thinking on this subject.

Reviewer: J.M. White is the Norman Hackerman Professor of Chemistry at the University of Texas at Austin.

Electron Energy Loss Spectroscopy in the Electron Microscope

R.F. Egerton
(Plenum Press, 1986)

Electron energy loss spectroscopy (EELS), as a technique for elemental analysis, dates from the pioneering work of Hillier and Baker at RCA in 1944. For much of the succeeding 40 years, EELS remained a laboratory curiosity, overshadowed by the successes of fluorescent x-ray microanalytical techniques. In the past ten years, however, with the development of electron microscopes combining small diameter probes, high beam energies, and good vacuum engineering, EELS has become an analytical tool of considerable importance. This new book, by one of the workers who has done most to establish the technique, finally marks the transition of transmission electron microscopy from a promising newcomer to an established performer.

The book is divided into five major sections, starting with an introduction and general survey of electron spectroscopy. Next comes a study of EELS instrumentation. This chapter is particularly welcome as it is perhaps the first detailed exposition of many of these topics in a readily accessible form. Anyone attempting to set up an EELS system for the first time will be grateful to have this material.

The next section, a detailed and thorough review of electron scattering theory, provides a comprehensive overview of all aspects of both elastic and inelastic scattering phenomena. While some of the theoretical material is quite advanced, the author has been careful to start each chapter with a review of basic concepts, and then build toward more complex ideas.

The last two chapters consider the application of EELS to qualitative and quantitative elemental analysis, and other applications of EELS including structural determinations using Extended Fine Structure (EXELFS), Near Edge Structure (XANE), and Compton Scattering methods.

The overall presentation of the book is good, although the reproduction of some of the experimental spectra, apparently photographed from screen displays, is less than ideal. Considerable care seems to have been taken to ensure uniform notation throughout the text and this, together with the careful explanations, excellent drawings, and practical illustrations, will make the book ideal for teaching use at the graduate level. The volume is further enhanced for use as a reference source by some useful appendices, such as a tabulation of characteristic plasmon loss values and a detailed listing of edge energies, a compilation in reasonably generic FORTRAN of the source code for some of the programs discussed in the text, and a good index.

The bibliography deserves a special word, as it is both comprehensive and fully annotated. Many of the references cited here are difficult to find elsewhere and this portion of the book will surely be one of the most heavily used. Anyone who is now using, or who is planning to use, EELS in an electron microscope will find this book invaluable as a reference and as an experimental guide.

Reviewer: David C. Joy is a member of the technical staff at AT&T Bell Laboratories, Murray Hill, NJ.

Applied Polymer Science

Edited by R.W. Tess and G.W. Poehlein

(American Chemical Society, 1985)

Applied Polymer Science covers a wide range of topics in current applications of polymers. The volume is divided into eight segments, each containing several chapters and making a total of 54. An introduction by Herman Mark provides a historical perspective of the field of polymers. The chapter by C.E. Carraher, Jr. and R.B. Seymour lays the foundation for all subsequent chapters. The second segment reviews in depth various modes of polymerization, including major industrial processes, such as free-radical, ionic, and condensation reactions. Block copolymer and multicomponent systems are also discussed in separate chapters. The next segment deals with structure-property relationships, with specific concentration on transport behavior, fracture mechanics, and flammability. Up to this point, the volume reads more like a graduate-level text, all the subjects

Continued

being essential knowledge for people practicing in the field.

The fourth segment covers specific polymer products, such as polyolefins, polystyrenes, engineering thermoplastics, fibers, foams, and resins for aerospace and medical applications. Here, individual chapters offer specialized information. Most are extensive reviews of the sub-area examined. Segment five is rather short, covering only aspects of polymer solutions and plasticization.

The remaining three segments constitute almost half the volume. These include detailed discussions of coating analysis (spectroscopy, electron microscopy, and rheology). Topics such as electrodeposition, curing, and methods of application are also discussed. An extensive list of coating materials is treated, e.g., epoxies, polyamides, urethanes, acrylics, cellulose acetates and esters, amino resins, silicon-containing resins, phenolics, alkyds and vinyls, etc. The science and technology of pigments and paint manufacture cap the volume with the final segment.

Overall, this volume serves the dual purpose of introducing the basic concepts and major developments to date in polymers, and of extensively reviewing polymer coatings and paints. The authors of the contributing chapters are all noted researchers. For practicing engineers in these industries, the volume is a much needed reference. It relieves beginners and even veterans of hours of labor-intensive literature search because the chapters are organized as effective capsules, updating the readers expediently.

However, with only a handful of new chapters since the 1975 edition that treat subjects of emerging importance, the volume does need future expansion. As the editors commented in the preface, "some promised chapters never were forthcoming and had to be abandoned." This is indeed regretful. Hopefully, the next edition will remedy the situation and offer improved coverage and even emphasis of a more diverse collection of sub-areas.

Reviewer: David S. Soong is on the faculty of the Department of Chemical Engineering at the University of California, Berkeley.

physics. A solid work of virtuosi, very attractively produced in all respects. Paper edition \$26.00. (NW)

QC793 85-30388 0-387-16054-X
Medium energy nucleon and antinucleon scattering; proceedings, Bad Honnef, Germany 1985.

Title main entry. Ed. by H.V. von Geramb (Lecture notes in physics; v.243)
 Springer-Verlag, ©1986 576 p. \$36.50 (pa)
 Thirty-nine technical papers — some experimental, some theoretical, and organized here under four topical heads — comprise the proceedings of a conference which was attended by European, Japanese and American nuclear physicists. Provides such persons with a useful account of some recent developments. (NW)

QC793 85-17472 0-521-26801-X
Story of the W and Z.

Watkins, Peter
 Cambridge U. Pr., ©1986 240 p. \$44.50
 Provides an account for general readers of one of the grand adventures of recent elementary particle physics — the heroic search for and discovery of a pair of elusive particles the existence of which tends to confirm the fundamental correctness of one of the most beautiful (and now influential) of physical theories. The whole complex enterprise involved scores of physicists (the author was a participant), and has resulted thus far in the award of five Nobel Prizes (three for theoretical contributions, two for experimental). The present volume is concerned mainly — though by no means exclusively — with experimental aspects of the story. An exciting story, nicely told. The volume has been handsomely put together, with many interesting photos and helpful figures. (NW) Ed. note: Another enthusiastic review of this book appeared in the July/August 1986 SciTech.

QC794 85-24403 0-306-42089-9
Heavy Ion Collisions; Cargese 1984.

NATO Advanced Study Institute (1984; Cargese, Corsica) (NATO ASI series. Series B, Physics; v.130)
 Plenum Press, ©1986 409 p. \$65.00
 Proceedings of a conference (Heavy Ion Collisions: From Collective Motions to Quarks) held in Corsica in September, 1984. Twelve theoretical/experimental papers review the state and prospects of a young field, in which the major experimental tools are (in many cases) just beginning to come on line. Graduate students and research physicists active in the field will find here much of enduring value. Attractively printed from typed plates. (NW)

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QD241 71-167779 0-12-040816-3
Annual reports in organic synthesis — 1985.

Title main entry. Ed. by Martin J. O'Donnell and Eric F.V. Scriven
 Academic Pr., ©1986 513 p. \$39.95 (pa)
 The latest edition of an annual reference which is a great expedient to any chemist concerned with synthesis and having no access to on-line data.

QD262 85-12601 0-387-15094-3
Solvomercuration/demercuration reactions in organic synthesis.

Larock, R.C. (Richard C.)
 Springer-Verlag, ©1986 607 p. \$189.50
 Organometallic reagents in organic synthesis have been a major development in organic chemistry in recent years. This is a comprehensive examination & review of the very valuable solvomercuration-demercuration sequence. Larock covers: hydromercuration, aloxy-, peroxy-, acloxy-,

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